



# RF Power LDMOS Transistor

## N-Channel Enhancement-Mode Lateral MOSFET

This 63 W asymmetrical Doherty RF power LDMOS transistor is designed for cellular base station applications requiring very wide instantaneous bandwidth capability covering the frequency range of 2300 to 2400 MHz.

### 2300 MHz

- Typical Doherty Single-Carrier W-CDMA Performance:  $V_{DD} = 30$  Vdc,  $I_{DQA} = 500$  mA,  $V_{GSB} = 0.7$  Vdc,  $P_{out} = 63$  W Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

| Frequency | $G_{ps}$<br>(dB) | $\eta_D$<br>(%) | Output PAR<br>(dB) | ACPR<br>(dBc) |
|-----------|------------------|-----------------|--------------------|---------------|
| 2300 MHz  | 15.6             | 49.3            | 8.4                | -30.1         |
| 2350 MHz  | 16.1             | 48.7            | 8.5                | -31.9         |
| 2400 MHz  | 16.1             | 48.0            | 8.2                | -32.7         |

### Features

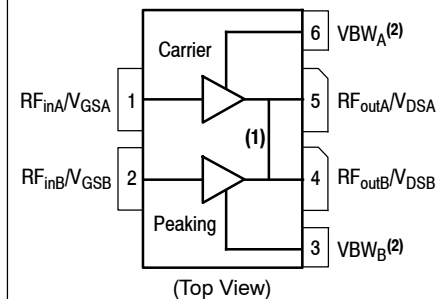
- Advanced high performance in-package Doherty
- Designed for wide instantaneous bandwidth applications
- Greater negative gate-source voltage range for improved Class C operation
- Able to withstand extremely high output VSWR and broadband operating conditions
- Designed for digital predistortion error correction systems

**A3T23H300W23SR6**

**2300–2400 MHz, 63 W AVG., 30 V  
AIRFAST RF POWER LDMOS  
TRANSISTOR**



**ACP-1230S-4L2S**



**Figure 1. Pin Connections**

- Pin connections 4 and 5 are DC coupled and RF independent.
- Device can operate with  $V_{DD}$  current supplied through pin 3 and pin 6.

**Table 1. Maximum Ratings**

| Rating                                                                                                                    | Symbol    | Value       | Unit      |
|---------------------------------------------------------------------------------------------------------------------------|-----------|-------------|-----------|
| Drain-Source Voltage                                                                                                      | $V_{DS}$  | -0.5, +65   | Vdc       |
| Gate-Source Voltage                                                                                                       | $V_{GS}$  | -6.0, +10   | Vdc       |
| Operating Voltage                                                                                                         | $V_{DD}$  | 32, +0      | Vdc       |
| Storage Temperature Range                                                                                                 | $T_{stg}$ | -65 to +150 | °C        |
| Case Operating Temperature Range                                                                                          | $T_C$     | -40 to +150 | °C        |
| Operating Junction Temperature Range (1,2)                                                                                | $T_J$     | -40 to +225 | °C        |
| CW Operation @ $T_C = 25^\circ\text{C}$ when DC current is fed through pin 3 and pin 6<br>Derate above $25^\circ\text{C}$ | CW        | 180<br>1.2  | W<br>W/°C |

**Table 2. Thermal Characteristics**

| Characteristic                                                                                                                                                                | Symbol          | Value (2,3) | Unit |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------|-------------|------|
| Thermal Resistance, Junction to Case<br>Case Temperature $73^\circ\text{C}$ , 63 W Avg., W-CDMA, 30 Vdc, $I_{DQA} = 500\text{ mA}$ ,<br>$V_{GSB} = 0.7\text{ Vdc}$ , 2350 MHz | $R_{\theta JC}$ | 0.17        | °C/W |

**Table 3. ESD Protection Characteristics**

| Test Methodology                      | Class |
|---------------------------------------|-------|
| Human Body Model (per JS-001-2017)    | 2     |
| Charge Device Model (per JS-002-2014) | C3    |

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

**Off Characteristics (4)**

|                                                                                                   |           |   |   |    |                 |
|---------------------------------------------------------------------------------------------------|-----------|---|---|----|-----------------|
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 65\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | — | — | 10 | $\mu\text{Adc}$ |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 32\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | — | — | 5  | $\mu\text{Adc}$ |
| Gate-Source Leakage Current<br>( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )              | $I_{GSS}$ | — | — | 1  | $\mu\text{Adc}$ |

**On Characteristics - Side A, Carrier**

|                                                                                                                  |              |     |      |     |     |
|------------------------------------------------------------------------------------------------------------------|--------------|-----|------|-----|-----|
| Gate Threshold Voltage<br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 140\text{ }\mu\text{Adc}$ )                        | $V_{GS(th)}$ | 1.3 | 1.8  | 2.3 | Vdc |
| Gate Quiescent Voltage<br>( $V_{DD} = 30\text{ Vdc}$ , $I_{DA} = 500\text{ mAdc}$ , Measured in Functional Test) | $V_{GSA(Q)}$ | 2.2 | 2.6  | 3.0 | Vdc |
| Drain-Source On-Voltage<br>( $V_{GS} = 10\text{ Vdc}$ , $I_D = 1.4\text{ Adc}$ )                                 | $V_{DS(on)}$ | 0.1 | 0.15 | 0.3 | Vdc |

**On Characteristics - Side B, Peaking**

|                                                                                           |              |     |      |     |     |
|-------------------------------------------------------------------------------------------|--------------|-----|------|-----|-----|
| Gate Threshold Voltage<br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 320\text{ }\mu\text{Adc}$ ) | $V_{GS(th)}$ | 0.8 | 1.2  | 1.6 | Vdc |
| Drain-Source On-Voltage<br>( $V_{GS} = 10\text{ Vdc}$ , $I_D = 3.2\text{ Adc}$ )          | $V_{DS(on)}$ | 0.1 | 0.15 | 0.3 | Vdc |

1. Continuous use at maximum temperature will affect MTTF.

2. MTTF calculator available at <http://www.nxp.com/RF/calculators>.

3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.

4. Side A and Side B are tied together for these measurements.

(continued)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (continued)

| Characteristic                                                                                                                                                                                                                                                                                                                                                                                                   | Symbol   | Min  | Typ   | Max   | Unit |
|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|------|-------|-------|------|
| <b>Functional Tests</b> <sup>(1,2,3)</sup> (In NXP Doherty Test Fixture, 50 ohm system) $V_{DD} = 30\text{ Vdc}$ , $I_{DQA} = 500\text{ mA}$ , $V_{GSB} = 0.7\text{ Vdc}$ , $P_{out} = 63\text{ W Avg.}$ , $f = 2300\text{ MHz}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset. |          |      |       |       |      |
| Power Gain                                                                                                                                                                                                                                                                                                                                                                                                       | $G_{ps}$ | 14.4 | 15.6  | 16.8  | dB   |
| Drain Efficiency                                                                                                                                                                                                                                                                                                                                                                                                 | $\eta_D$ | 46.7 | 49.3  | —     | %    |
| $P_{out}$ @ 3 dB Compression Point, CW                                                                                                                                                                                                                                                                                                                                                                           | P3dB     | 55.3 | 56.2  | —     | dBm  |
| Adjacent Channel Power Ratio                                                                                                                                                                                                                                                                                                                                                                                     | ACPR     | —    | -29.0 | -26.0 | dBc  |

**Load Mismatch** <sup>(3)</sup> (In NXP Doherty Test Fixture, 50 ohm system)  $I_{DQA} = 500\text{ mA}$ ,  $V_{GSB} = 0.7\text{ Vdc}$ ,  $f = 2350\text{ MHz}$ , 12  $\mu\text{sec(on)}$ , 10% Duty Cycle

|                                                                                                              |                       |
|--------------------------------------------------------------------------------------------------------------|-----------------------|
| VSWR 10:1 at 32 Vdc, 360 W Pulsed CW Output Power<br>(3 dB Input Overdrive from 210 W Pulsed CW Rated Power) | No Device Degradation |
|--------------------------------------------------------------------------------------------------------------|-----------------------|

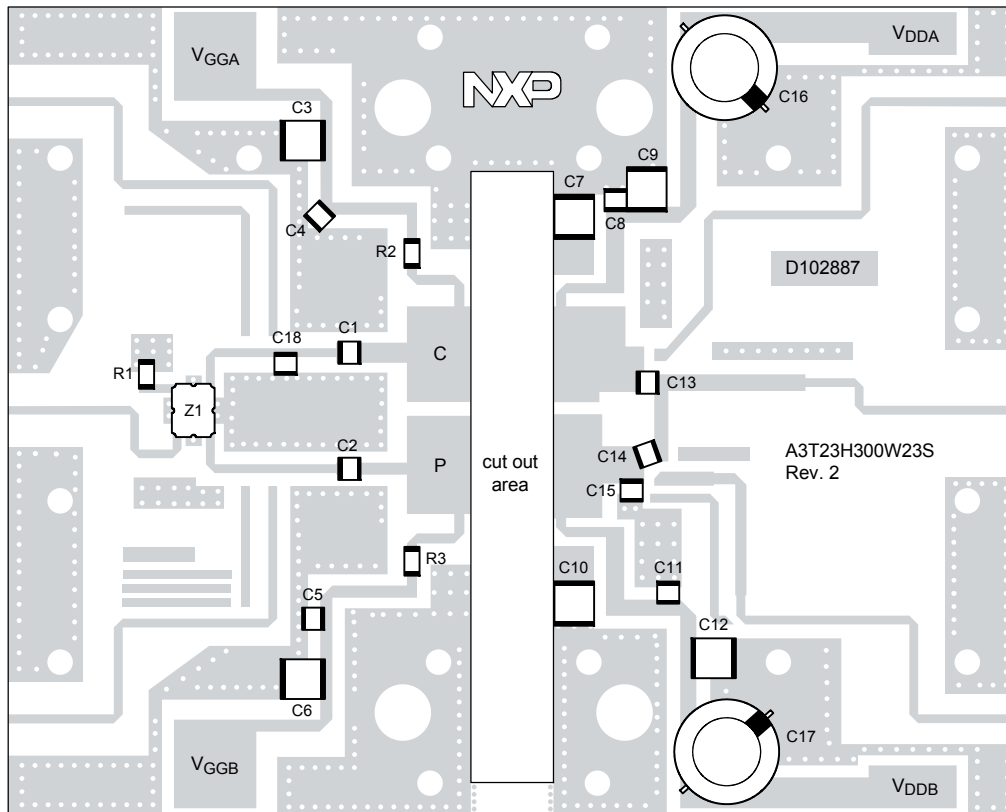
**Typical Performance** <sup>(3)</sup> (In NXP Doherty Test Fixture, 50 ohm system)  $V_{DD} = 30\text{ Vdc}$ ,  $I_{DQA} = 500\text{ mA}$ ,  $V_{GSB} = 0.7\text{ Vdc}$ , 2300–2400 MHz Bandwidth

|                                                                                                    |                  |   |       |   |       |
|----------------------------------------------------------------------------------------------------|------------------|---|-------|---|-------|
| $P_{out}$ @ 3 dB Compression Point <sup>(4)</sup>                                                  | P3dB             | — | 410   | — | W     |
| AM/PM<br>(Maximum value measured at the P3dB compression point across the 2300–2400 MHz bandwidth) | $\Phi$           | — | -18   | — | °     |
| VBW Resonance Point<br>(IMD Third Order Intermodulation Inflection Point)                          | $VBW_{res}$      | — | 230   | — | MHz   |
| Gain Flatness in 100 MHz Bandwidth @ $P_{out} = 63\text{ W Avg.}$                                  | $G_F$            | — | 0.4   | — | dB    |
| Gain Variation over Temperature<br>(-40°C to +85°C)                                                | $\Delta G$       | — | 0.007 | — | dB/°C |
| Output Power Variation over Temperature<br>(-40°C to +85°C)                                        | $\Delta P_{1dB}$ | — | 0.003 | — | dB/°C |

**Table 5. Ordering Information**

| Device          | Tape and Reel Information                             | Package        |
|-----------------|-------------------------------------------------------|----------------|
| A3T23H300W23SR6 | R6 Suffix = 150 Units, 56 mm Tape Width, 13-inch Reel | ACP-1230S-4L2S |

1.  $V_{DDA}$  and  $V_{ddb}$  must be tied together and powered by a single DC power supply.
2. Part internally matched both on input and output.
3. Measurements made with device in an asymmetrical Doherty configuration.
4.  $P_{3dB} = P_{avg} + 7.0\text{ dB}$  where  $P_{avg}$  is the average output power measured using an unclipped W-CDMA single-carrier input signal where output PAR is compressed to 7.0 dB @ 0.01% probability on CCDF.



Note:  $V_{DDA}$  and  $V_{DDB}$  must be tied together and powered by a single DC power supply.

aaa-030921

**Figure 2. A3T23H300W23SR6 Test Circuit Component Layout**

**Table 6. A3T23H300W23SR6 Test Circuit Component Designations and Values**

| Part                         | Description                                  | Part Number         | Manufacturer |
|------------------------------|----------------------------------------------|---------------------|--------------|
| C1, C2, C4, C5, C8, C11, C14 | 6.2 pF Chip Capacitor                        | ATC100B6R2BT500XT   | ATC          |
| C3, C6, C7, C9, C10, C12     | 10 $\mu$ F Chip Capacitor                    | C5750X7S2A106M230KB | TDK          |
| C13                          | 3.3 pF Chip Capacitor                        | ATC100B3R3CT500XT   | ATC          |
| C15                          | 0.8 pF Chip Capacitor                        | ATC100B0R8BT500XT   | ATC          |
| C16, C17                     | 470 $\mu$ F, 63 V Electrolytic Capacitor     | MCGPR63V477M13X26   | Multicomp    |
| C18                          | 0.3 pF Chip Capacitor                        | ATC100B0R3BT500XT   | ATC          |
| R1                           | 50 $\Omega$ , 30 W Termination Resistor      | RFP-375375N6Z50-2   | Anaren       |
| R2, R3                       | 3.6 $\Omega$ , 1/4 W Chip Resistor           | CRCW12063R60FKEA    | Vishay       |
| Z1                           | 2300–2700 MHz Band, 90°, 2 dB Hybrid Coupler | X3C25P1-02S         | Anaren       |
| PCB                          | Rogers RO4350B, 0.020", $\epsilon_r = 3.66$  | D102887             | MTL          |

|                                                   |  |                    |                                      |                            |  |
|---------------------------------------------------|--|--------------------|--------------------------------------|----------------------------|--|
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| TITLE:<br><br>ACP-1230S-4L2S                      |  |                    | DOCUMENT NO: 98ASA00974D      REV: A |                            |  |
|                                                   |  |                    | STANDARD: NON-JEDEC                  |                            |  |
|                                                   |  |                    | SOT1800-4      21 JUN 2017           |                            |  |

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

2. CONTROLLING DIMENSION: INCH

3. DIMENSIONS H1 AND H2 ARE MEASURED .030 INCH (0.762 MM) AWAY FROM FLANGE PARALLEL TO DATUM B. H1 APPLIES TO PINS 1, 2, 4 & 5. H2 APPLIES TO PINS 3 & 6.

4. TOLERANCE OF DIMENSION H2 IS TENTATIVE.

5. THESE SURFACES OF THE HEAT SLUG ARE NOT PART OF THE SOLDERABLE SURFACES AND MAY REMAIN UNPLATED.

6. DATUM H IS LOCATED AT THE BOTTOM OF THE LEAD FRAME AND IS COINCIDENT WITH THE LEAD WHERE THE LEADS EXIT THE PLASTIC BODY.

7. DIMENSIONS M AND S DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .012 INCH (0.30 MM) PER SIDE. DIMENSIONS M AND S DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.

8. DIMENSIONS D, U AND K DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .010 INCH (0.25 MM) TOTAL IN EXCESS OF THE D, U AND K DIMENSION AT MAXIMUM MATERIAL CONDITION.

9. DATUM A AND B TO BE DETERMINED AT DATUM T.

| DIM                                              | INCHES    |       | MILLIMETERS        |       | DIM                                  | INCHES                     |       | MILLIMETERS |       |
|--------------------------------------------------|-----------|-------|--------------------|-------|--------------------------------------|----------------------------|-------|-------------|-------|
|                                                  | MIN       | MAX   | MIN                | MAX   |                                      | MIN                        | MAX   | MIN         | MAX   |
| AA                                               | 1.265     | 1.275 | 32.13              | 32.39 | S                                    | .365                       | .375  | 9.27        | 9.53  |
| BB                                               | .395      | .405  | 10.03              | 10.29 | U                                    | .035                       | .045  | 0.89        | 1.14  |
| CC                                               | .160      | .190  | 4.06               | 4.83  | V1                                   | .640                       | .655  | 16.26       | 16.64 |
| D                                                | .455      | .465  | 11.56              | 11.81 | W1                                   | .105                       | .115  | 2.67        | 2.92  |
| E                                                | .062      | .069  | 1.57               | 1.75  | W2                                   | .135                       | .145  | 3.43        | 3.68  |
| F                                                | .004      | .007  | 0.10               | 0.18  | W3                                   | .245                       | .255  | 6.22        | 6.48  |
| H1                                               | .082      | .090  | 2.08               | 2.29  | W4                                   | .265                       | .281  | 6.73        | 7.14  |
| H2                                               | .078      | .094  | 1.98               | 2.39  | Y                                    | 0.695 BSC                  |       | 17.65 BSC   |       |
| K                                                | .175      | .195  | 4.45               | 4.95  | Z1                                   | R.000                      | R.040 | R0.00       | R1.02 |
| L                                                | 0.270 BSC |       | 6.86 BSC           |       | Z2                                   | .060                       | .100  | 1.52        | 2.54  |
| M                                                | 1.219     | 1.241 | 30.96              | 31.52 | aaa                                  | .015                       |       | 0.38        |       |
| N                                                | 1.218     | 1.242 | 30.94              | 31.55 | bbb                                  | .010                       |       | 0.25        |       |
| R                                                | .365      | .375  | 9.27               | 9.53  | ccc                                  | .020                       |       | 0.51        |       |
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|                                                  |           |       |                    |       | STANDARD: NON-JEDEC                  |                            |       |             |       |
|                                                  |           |       |                    |       | SOT1800-4      21 JUN 2017           |                            |       |             |       |

## PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

### Application Notes

- AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator
- .s2p File

### Development Tools

- Printed Circuit Boards

### To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

## REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date      | Description                                                                     |
|----------|-----------|---------------------------------------------------------------------------------|
| 0        | July 2018 | <ul style="list-style-type: none"><li>• Initial release of data sheet</li></ul> |

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